

BTA416X-800CT

3Q Hi-Com Triac Rev.02 - 30 January 2024

Product data sheet

1. General description

Planar passivated high commutation three quadrant triac in a TO220F "full pack" plastic package intended for use in circuits where high static and dynamic dV/dt and high dI/dt can occur. This "series C" triac will commutate the full RMS current at the maximum rated junction temperature without the aid of a snubber. This device has high T_i operating capability.

2. Features and benefits

- 3Q technology for improved noise immunity •
- High commutation capability with maximum false trigger immunity •
- High immunity to false turn-on by dV/dt
- High surge capability
- High T_{j(max)}
- Least sensitive gate for highest noise immunity
- Planar passivated for voltage ruggedness and reliability
- Triggering in three quadrants only
- Epoxy package meets UL94V-0 which guaranteed by epoxy molding compound
- Isolated package ($V_{iso} = 2500 V_{RMS}$)
- UL 1557 certified (file ref. E346397)

3. Applications

- Electronic thermostats (heating and cooling)
- High power motor controls •
- Rectifier-fed DC inductive loads e.g. DC motors and solenoids

4. Quick reference data -

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Symbol	Parameter	Conditions	Values			Unit	
Absolute	maximum rating						
V_{DRM}	repetitive peak off-state voltage		800				V
$I_{T(RMS)}$	RMS on-state current	full sine wave; T _h ≤ 92 °C; <u>Fig. 1; Fig. 2; Fig. 3</u>	16			A	
I _{TSM}	non-repetitive peak on- state current	full sine wave; T _{j(init)} = 25 °C; t _p = 20 ms; <u>Fig. 4; Fig. 5</u>				A	
		full sine wave; $T_{j(init)}$ = 25 °C; t_p = 16.7 ms			176		А
Tj	junction temperature		150		°C		
Symbol	Parameter	Conditions		Min	Тур	Max	Unit
Static ch	aracteristics						
I _{GT}	gate trigger current	$V_{D} = 12 \text{ V}; I_{T} = 0.1 \text{ A}; \text{ T2+ G+};$ $T_{j} = 25 \text{ °C}; \text{ Fig. 7}$		2	-	35	mA
		V _D = 12 V; I _T = 0.1 A; T2+ G-; T _j = 25 °C; <u>Fig. 7</u>		2	-	35	mA
		V _D = 12 V; I _T = 0.1 A; T2- G-; T _i = 25 °C; <u>Fig. 7</u>		2	-	35	mA

Symbol	Parameter	Conditions	Min	Тур	Max	Unit
I _H	holding current	V _D = 12 V; T _j = 25 °C; <u>Fig. 9</u>	-	-	35	mA
V _T	on-state voltage	I _T = 20 A; T _j = 25 °C; <u>Fig. 10</u>	-	1.2	1.45	V
Dynamic	characteristics					
dV _D /dt	rate of rise of off-state voltage	V_{DM} = 536 V; T _j = 125 °C; (V _{DM} = 67% of V _{DRM}); exponential waveform; gate open circuit	1000	-	-	V/µs
dl _{com} /dt	rate of change of commutating current	$V_D = 400 \text{ V}; \text{ T}_j = 125 \text{ °C}; \text{ I}_{T(RMS)} = 16 \text{ A};$ $dV_{com}/dt = 20 \text{ V}/\mu \text{s}; \text{ (snubberless condition); gate open circuit}$	10	-	-	A/ms

5. Pinning information

Table 2.	Pinning infor	mation		
Pin	Symbol	Description	Simplified outline	Graphic symbol
1	T1	main terminal 1		N
2	T2	main terminal 2		
3	G	gate		sym051
mb	n.c.	mounting base; isolated	$\begin{bmatrix} O \\ 1 \\ 2 \\ 3 \\ 1 \\ 2 \\ 3 \\ 1 \\ 2 \\ 3 \\ 1 \\ 2 \\ 3 \\ 1 \\ 2 \\ 3 \\ 1 \\ 2 \\ 3 \\ 1 \\ 2 \\ 3 \\ 1 \\ 2 \\ 3 \\ 1 \\ 2 \\ 3 \\ 1 \\ 2 \\ 3 \\ 1 \\ 2 \\ 3 \\ 1 \\ 2 \\ 3 \\ E \\ d \\ \end{bmatrix}$	

6. Ordering information

Table 3. Ordering information									
Type number	Package	Orderable part number	Packing	Small packing	Package	Package			
	Name		method	quantity	version	issue date			
BTA416X-800CT	TO220F	BTA416X-800CTQ	Tube	50	TO220FE (E)	25-Sep-2020			
BTA416X-800CT	TO220F	BTA416X-800CT,127	Tube	50	SOT186A (d)	14-Nov-2013			

7. Marking

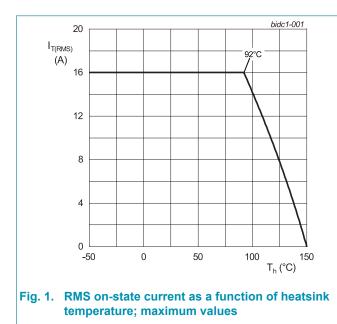
Table 4. Marking codes					
Type number	Marking codes				
	Assembly factory: E	Assembly factory: d			
BTA416X-800CT	BTA416X 800CT PJExxxx xx	BTA416X 800CT PJdxxxx xx			

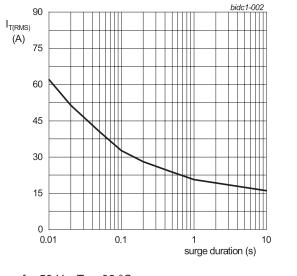
8. Limiting values

Table 5. Limiting values

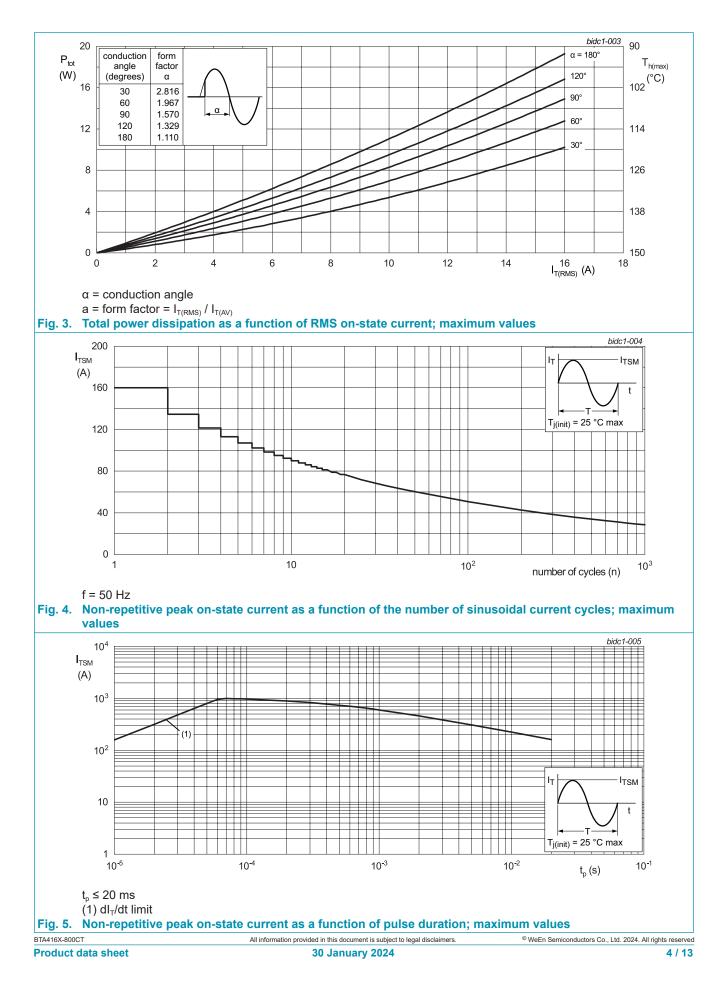
In accordance with the Absolute Maximum Rating System (IEC 60134).

Symbol	Parameter	Conditions	Values	Unit
V_{DRM}	repetitive peak off-state voltage		800	V
$I_{T(RMS)}$	RMS on-state current	full sine wave; T _h ≤ 92 °C; <u>Fig 1</u> ; <u>Fig 2</u> ; <u>Fig 3</u>	16	A
I _{TSM}	non-repetitive peak on- state current	full sine wave; $T_{j(init)}$ = 25 °C; t_p = 20 ms; Fig 4; Fig 5	160	A
		full sine wave; $T_{j(init)}$ = 25 °C; t_p = 16.7 ms	176	A
l ² t	I ² t for fusing	t _P = 10 ms; SIN	128	A ² s
dl _T /dt	rate of rise of on-state current	I _G = 0.2 A	100	A/µs
I _{GM}	peak gate current		4	A
P_{GM}	peak gate power		5	W
$P_{G(AV)}$	average gate power	over any 20 ms period	1	W
T _{stg}	storage temperature		-40 to 150	°C
Tj	junction temperature		150	°C



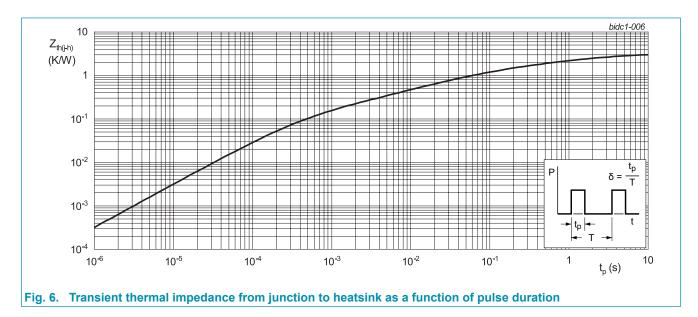






9. Thermal characteristics

Symbol	Parameter	Conditions	Min	Тур	Мах	Unit
$R_{th(j-h)}$	thermal resistance from junction to heatsink	full cycle; with heatsink compound; Fig. 6	-	-	3	K/W
$R_{\text{th(j-a)}}$	thermal resistance from junction to ambient	in free air	-	55	-	K/W

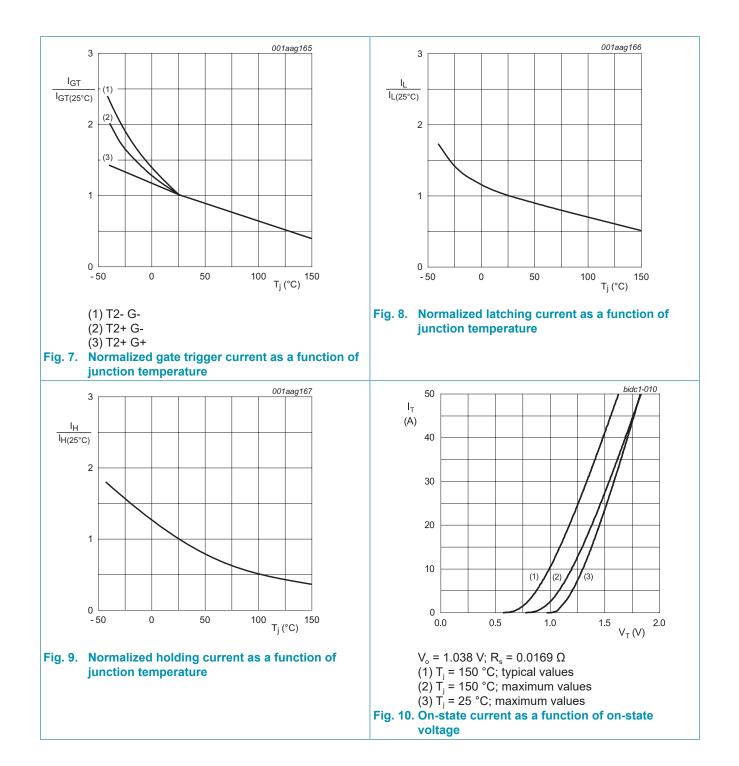


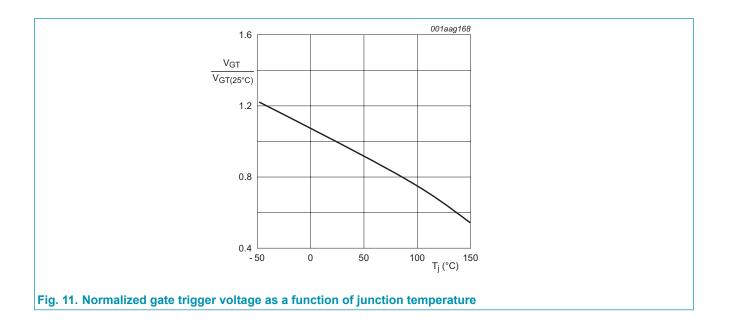
10. Isolation characteristics

Symbol	Parameter	Conditions	Min	Тур	Мах	Unit
$V_{\text{isol}(\text{RMS})}$	RMS isolation voltage	from all terminals to external heatsink; sinusoidal waveform; clean and dust free; 50 Hz \leq f \leq 60 Hz; RH \leq 65 %; T _h = 25 °C	-	-	2500	V
C_{isol}	isolation capacitance	from main terminal 2 to external heatsink; f = 1 MHz; $T_h = 25 \degree C$	-	10	-	pF

11. Characteristics

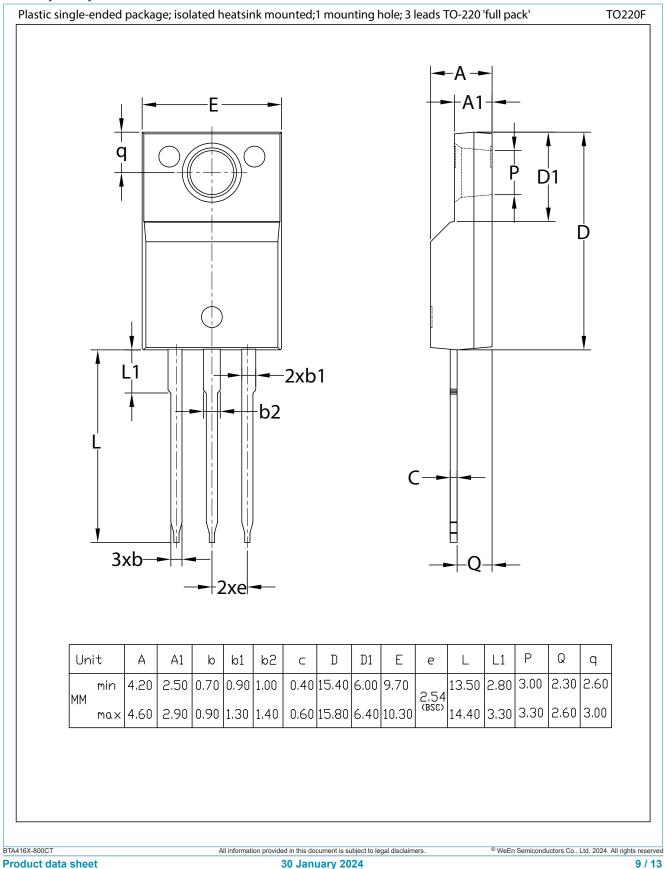
Symbol	Parameter	Conditions	Min	Тур	Max	Unit
Static cha	racteristics					
I _{GT}	gate trigger current	$V_{D} = 12 \text{ V}; \text{ I}_{T} = 0.1 \text{ A}; \text{ T2+ G+};$ T _j = 25 °C; Fig. 7	2	-	35	mA
		$V_{\rm D}$ = 12 V; I _T = 0.1 A; T2+ G-; T _j = 25 °C; Fig. 7	2	-	35	mA
		$V_{D} = 12 \text{ V}; \text{ I}_{T} = 0.1 \text{ A}; \text{ T2- G-};$ $T_{j} = 25 \text{ °C}; \text{ Fig. 7}$	2	-	35	mA
IL	latching current	$V_{D} = 12 V; I_{G} = 0.1 A; T2+G+;$ T _j = 25 °C; Fig. 8	-	-	50	mA
		V_{D} = 12 V; I _G = 0.1 A; T2+ G-; T _j = 25 °C; Fig. 8	-	-	60	mA
		V_{D} = 12 V; I_{G} = 0.1 A; T2- G-; T _j = 25 °C; Fig. 8	-	-	50	mA
I _H	holding current	V _D = 12 V; T _j = 25 °C; <u>Fig. 9</u>	-	-	35	mA
V _T	on-state voltage	I _T = 20 A; T _j = 25 °C; <u>Fig. 10</u>	-	1.2	1.45	V
$V_{\rm GT}$	gate trigger voltage	$V_{\rm D}$ = 12 V; I _T = 0.1 A; T _j = 25 °C; Fig. 11	-	0.7	1	V
		V _D = 400 V; I _T = 0.1 A; T _j = 150 °C	0.25	0.4	-	V
I _D	off-state current	$V_{\rm D}$ = 800 V; T _j = 25 °C	-	-	5	μA
		V _D = 800 V; T _j = 125 °C	-	0.1	0.5	mA
		V _D = 800 V; T _j = 150 °C	-	0.4	2	mA
Dynamic	characteristics					
dV _D /dt	rate of rise of off-state voltage	V_{DM} = 536 V; T _j = 125 °C; (V _{DM} = 67% of V _{DRM}); exponential waveform; gate open circuit	1000	-	-	V/µs
		V_{DM} = 536 V; T _j = 150 °C; (V _{DM} = 67% of V _{DRM}); exponential waveform; gate open circuit	500	-	-	V/µs
dl _{com} /dt	rate of change of commutating current	V_{D} = 400 V; T _j = 125 °C; I _{T(RMS)} = 16 A; dV _{com} /dt = 20 V/µs; (snubberless condition); gate open circuit	10	-	-	A/ms
		V_D = 400 V; T _j = 150 °C; I _{T(RMS)} = 16 A; dV _{com} /dt = 20 V/µs; (snubberless condition); gate open circuit	5	-	-	A/ms



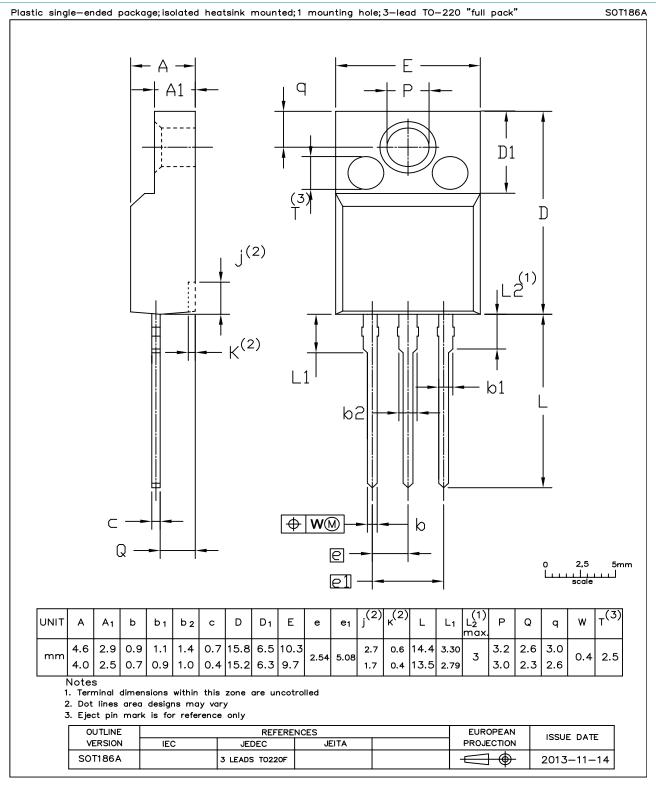


12. Package outline

Assembly factory: E



Assembly factory: d



BTA416X-800CT **Product data sheet**

13. Legal information

Data sheet status

Document status [1][2]	Product status [3]	Definition
Objective [short] data sheet	Development	This document contains data from the objective specification for product development.
Preliminary [short] data sheet	Qualification	This document contains data from the preliminary specification.
Product [short] data sheet	Production	This document contains the product specification.

[1] Please consult the most recently issued document before initiating or completing a design.

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